INFORMATION DISCLOSURE STATEMENT BY APPLICANTS PTO-1449 Sheet 1 of 2	Application No. 10/526,823 Filing Date: March 4, 2005 First Named Inventor: Richard Malick AMBROSI Art Unit: Unassigned Examiner Name: Constantine Hannaher Attorney Docket No. 77165-0013

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U.S. PATENT DOCUMENTS

Examiner Initial	Document No. Kind Code (if known)	Name of Patentee or Applicants	Publication or Issue Date (MM-DD-YYYY)

FOREIGN PATENT DOCUMENTS

Examiner Initial	Foreign Patent Document			Name of Patentee or Applicant	Date of Publication
	Office	Number	Kind		
	~~GB~~	~~1455011~~		Jozef Antoon Van Biesen et al.	~~10/11/1976~~
	~~FR~~	~~2.053.599~~		~~Philippe Chevalier~~	~~16/04/1971~~
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OTHER PRIOR ART OR NON-PATENT LITERATURE DOCUMENTS

Examiner Initial	Document Title	T
	~~Ambrosi, Richard M., et al., "*Physics of Image Formation in Accelerator-based Fast Neutron Radiography,*" SPIE Vol. 4142, (2000), pp. 331-344.~~	Y
	~~Feller, W.B., et al., "*Neutron field imaging with microchannel plates,*" SPIE Vol. 4141 (2000), pp. 291-302.~~	Y
/CH/	Downing, R.G., et al., "*High Spatial-Resolution Imaging of Low Energy Neutrons with MicroChannel Plates,*" Transactions of the American Nuclear Society, Vol. 82, (June 4-8, 2000), pp. 83-84.	Y
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Examiner Signature: /Constantine Hannaher/ Date Considered: 04/23/2007

Evidence of consideration previously returned see Paper No. 20061025

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	Attorney Docket No. 77165-0013

Examiner: Initial if citation considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicants.